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Application No.	Applicant(s)	
08/978,217	BENZ ET AL.	
Examiner	Art Unit	
Anne Holleran	1642	

SEARCHED			
Class	Subclass	Date	Examiner
536	23.1	3/5/2004	ALH
	23.5		
	24.3		
y	24.31		
435	69.1		
	70.1		
	320.1		
<u></u>	325	$\overline{\lambda}$	<u>\</u>

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCH		) ·
	DATE	EXMR
updated STIC search of sequences, request in file	2/13/2004	ALH
consulted SPE Eyler regarding 112, 2 <sup>nd</sup> and 112, 1st	3/5/2004	ALH
updated search of U.S. Patents in EAST(BRS)	3/5/2004	ALH